

Vibration Rejecting ±250°/s Yaw Rate Gyro

Preliminary Technical Data

ADXRS642

FEATURES

Complete rate gyroscope on a single chip Z-axis (yaw rate) response 20°/hour bias stability 0.02°/√second angle random walk High vibration rejection over wide frequency 10,000 g powered shock survivability Ratiometric to referenced supply 5 V single-supply operation -40°C to +105°C operation Self-test on digital command Ultrasmall and light (<0.15 cc, <0.5 gram) **Temperature sensor output RoHS** compliant

APPLICATIONS

Industrial applications Inertial Measurement Units Severe Mechanical Environments Platform stabilization

GENERAL DESCRIPTION

The ADXRS642 is a complete angular rate sensor (gyroscope) that uses the Analog Devices, Inc., surface-micromachining process to make a functionally complete and low cost angular rate sensor integrated with all of the required electronics on one chip. The manufacturing technique for this device is a patented high volume BiMOS process with years of proven field reliability.

The ADXRS642 is an industrial grade gyroscope that is 100% pin, package, temperature, and function compatible with the ADXRS622 and ADXRS652 - while offering enhanced vibration rejection

The output signal, RATEOUT (1B, 2A), is a voltage proportional to angular rate about the axis normal to the top surface of the package. The measurement range is a minimum of ±250°/s. The output is ratiometric with respect to a provided reference supply. Other external capacitors are required for operation.

A temperature output is provided for compensation techniques. Two digital self-test inputs electromechanically excite the sensor to test proper operation of both the sensor and the signal conditioning circuits. The ADXRS642 is available in a 7 mm \times 7 mm \times 3 mm BGA chip-scale package.

FUNCTIONAL BLOCK DIAGRAM

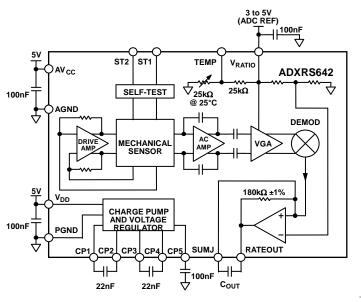


Figure 1. Block Diagram

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SPECIFICATIONS

All minimum and maximum specifications are guaranteed. Typical specifications are not guaranteed.

 $T_A = 25$ °C, $V_S = AV_{CC} = V_{DD} = 5$ V, $V_{RATIO} = AV_{CC}$, angular rate = 0°/sec, bandwidth = 80 Hz ($C_{OUT} = 0.01~\mu F$), $I_{OUT} = 100~\mu A$, $\pm 1~g$, unless otherwise noted.

Table 1.

Parameter	Conditions	Min	Тур	Max	Unit
SENSITIVITY ¹	Clockwise rotation is positive output				
Measurement Range ²	Full-scale range over specifications range	±250	±300		°/sec
Initial and Over Temperature	-40°C to +105°C		7.0		mV/°/sec
Temperature Drift ³		±2		%	
Nonlinearity	Best fit straight line	0.01			% of FS
NULL ¹					
Null	-40°C to +105°C		2.5		V
Calibrated Null ⁷	-40°C to +105°C		±0.1		°/sec
Temperature Drift	-40°C to +105°C		±1		°/sec
Linear Acceleration Effect	Any axis		0.03		°/sec/g
Vibration Rectification	25g RMS, 50Hz to 5kHz		0.0002		°/s/g²
NOISE PERFORMANCE					
Rate Noise Density	T _A ≤ 25°C		0.02		°/sec/√Hz
Resolution Floor	$T_A = 25$ °C 1 minute to 1 hour in-run		20		°/hr
FREQUENCY RESPONSE					
Bandwidth ⁴	±3dB user adjustable up to		2000		Hz
Sensor Resonant Frequency		16	18	20	kHz
SELF-TEST ¹					
ST1 RATEOUT Response	ST1 pin from Logic 0 to Logic 1		-45		°/sec
ST2 RATEOUT Response	ST2 pin from Logic 0 to Logic 1		45		°/sec
ST1 to ST2 Mismatch⁵		-5	±2	5	%
Logic 1 Input Voltage		3.3			V
Logic 0 Input Voltage				1.7	V
Input Impedance	To common	40	50	100	kΩ
TEMPERATURE SENSOR ¹					
V _{OUT} at 25°C	Load = $10 \text{ M}\Omega$	2.35	2.5	2.65	V
Scale Factor ⁶	25°C, V _{RATIO} = 5 V		9		mV/°C
Load to V _S			25		kΩ
Load to Common			25		kΩ
TURN-ON TIME ⁷	Power on to $\pm 0.5^{\circ}$ /s of final with CP5 = 100nF			50	ms
OUTPUT DRIVE CAPABILITY					
Current Drive	For rated specifications			200	μΑ
Capacitive Load Drive	·			1000	pF
POWER SUPPLY					
Operating Voltage (Vs)		4.75	5.00	5.25	V
Quiescent Supply Current			3.5	4.5	mA
TEMPERATURE RANGE					
Specified Performance		-40		+105	°C

 $^{^{\}mbox{\tiny 1}}$ Parameter is linearly ratiometric with $V_{\mbox{\tiny RATIO}}.$

² Measurement range is the maximum range possible, including output swing range, initial offset, sensitivity, offset drift, and sensitivity drift at 5 V supplies.

 $^{^3}$ From +25°C to -40°C or +25°C to +105°C.

⁴ Adjusted by external capacitor, Cout. Reducing bandwidth below 0.01 Hz does not result in further noise improvement.

 $^{^{5}}$ Self-test mismatch is described as (ST2 + ST1)/((ST2 - ST1)/2).

⁶ Scale factor for a change in temperature from 25°C to 26°C. V_{TEMP} is ratiometric to V_{RATIO}. See the Temperature Output and Calibration section for more information.

⁷ Based on characterization

ABSOLUTE MAXIMUM RATINGS

Table 2.

Parameter	Rating
Acceleration (Any Axis, 0.5 ms)	
Unpowered	3,000 <i>g</i>
Powered	3,000 <i>g</i>
V_{DD} , AV_{CC}	-0.3 V to +6.0 V
V _{RATIO}	AV cc
ST1, ST2	AV_{CC}
Output Short-Circuit Duration (Any Pin to Common)	Indefinite
Operating Temperature Range	−55°C to +125°C
Storage Temperature Range	−65°C to +150°C

Stresses above those listed under the Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Drops onto hard surfaces can cause shocks of greater than 10,000 *g* and can exceed the absolute maximum rating of the device. Care should be exercised in handling to avoid damage.

RATE SENSITIVE AXIS

This is a Z-axis rate-sensing device (also called a yaw rate-sensing device). It produces a positive going output voltage for clockwise rotation about the axis normal to the package top, that is, clockwise when looking down at the package lid.

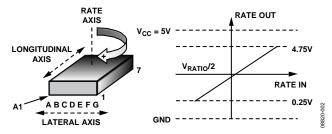


Figure 2. RATEOUT Signal Increases with Clockwise Rotation

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

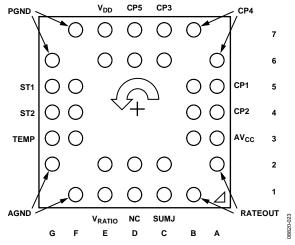


Figure 3. Pin Configuration

Table 3. Pin Function Descriptions

Pin No.	Mnemonic	Description
6D, 7D	CP5	HV Filter Capacitor, 100nF.
6A, 7B	CP4	Charge Pump Capacitor, 22 nF.
6C, 7C	CP3	Charge Pump Capacitor, 22 nF.
5A, 5B	CP1	Charge Pump Capacitor, 22 nF.
4A, 4B	CP2	Charge Pump Capacitor, 22 nF.
3A, 3B	AV _{CC}	Positive Analog Supply.
1B, 2A	RATEOUT	Rate Signal Output.
1C, 2C	SUMJ	Output Amp Summing Junction.
1D, 2D	NC	Do Not Connect.
1E, 2E	V _{RATIO}	Reference Supply for Ratiometric Output.
1F, 2G	AGND	Analog Supply Return.
3F, 3G	TEMP	Temperature Voltage Output.
4F, 4G	ST2	Self-Test for Sensor 2.
5F, 5G	ST1	Self-Test for Sensor 1.
6G, 7F	PGND	Charge Pump Supply Return.
6E, 7E	V_{DD}	Positive Charge Pump Supply.

THEORY OF OPERATION

The ADXRS642 operates on the principle of a resonator gyro. Figure 4 shows a simplified version of one of four polysilicon sensing structures. Each sensing structure contains a dither frame that is electrostatically driven to resonance. This produces the necessary velocity element to produce a Coriolis force when experiencing angular rate. The ADXRS642 is designed to sense a Z-axis (yaw) angular rate.

When the sensing structure is exposed to angular rate, the resulting Coriolis force couples into an outer sense frame, which contains movable fingers that are placed between fixed pickoff fingers. This forms a capacitive pickoff structure that senses Coriolis motion. The resulting signal is fed to a series of gain and demodulation stages that produce the electrical rate signal output. The quad sensor design rejects linear and angular acceleration, including external *g*-forces and vibration. This is achieved by mechanically coupling the four sensing structures such that external *g*-forces appear as common-mode signals that can be removed by the fully differential architecture implemented in the ADXRS642.

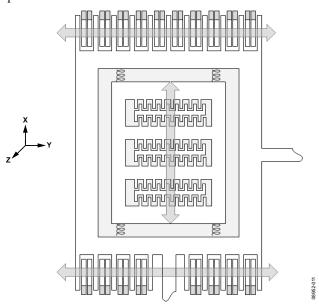


Figure 4. Simplified Gyro Sensing Structure – One Corner

The electrostatic resonator requires 18 to 20V for operation. Because only 5V are typically available in most applications, a charge pump is included on chip. If an external 18 to 20V supply is available, the two capacitors on CP1 to CP4 can be omitted, and this supply can be connected to CP5 (Pin 6D, Pin 7D). CP5 should not be grounded when power is applied to the ADXRS642. No damage occurs, but under certain conditions, the charge pump may fail to start up after the ground is removed without first removing power from the ADXRS642.

SETTING BANDWIDTH

External Capacitor C_{OUT} is used in combination with the onchip R_{OUT} resistor to create a low-pass filter to limit the bandwidth of the ADXRS642 rate response. The -3 dB frequency set by R_{OUT} and C_{OUT} is

$$f_{OUT} = 1/(2 \times \pi \times R_{OUT} \times C_{OUT})$$

and can be well controlled because R_{OUT} has been trimmed during manufacturing to be 180 k Ω \pm 1%. Any external resistor applied between the RATEOUT pin (1B, 2A) and SUMJ pin (1C, 2C) results in

$$R_{OUT} = \left(180 \text{ k}\Omega \times R_{EXT}\right) / \left(180 \text{ k}\Omega + R_{EXT}\right)$$

In general, an additional filter (in either hardware or software) is added to attenuate high frequency noise arising from demodulation spikes at the 18 kHz resonant frequency of the gyro. An R/C output filter consisting of a 3.3k series resistor and 22nF shunt capacitor (2.2kHz pole) is recommended.

TEMPERATURE OUTPUT AND CALIBRATION

It is common practice to temperature-calibrate gyros to improve their overall accuracy. The ADXRS642 has a temperature proportional voltage output that provides input to such a calibration method. The temperature sensor structure is shown in Figure . The temperature output is characteristically nonlinear, and any load resistance connected to the TEMP output results in decreasing the TEMP output and its temperature coefficient. Therefore, buffering the output is recommended.

The voltage at TEMP (3F, 3G) is nominally 2.5 V at 25°C, and $V_{RATIO} = 5$ V. The temperature coefficient is ~9 mV/°C at 25°C. Although the TEMP output is highly repeatable, it has only modest absolute accuracy.

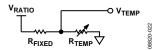


Figure 5. Temperature Sensor Structure

SUPPLY RATIOMETRICITY

The AD642's RATEOUT, ST1, ST2, and TEMP signals are ratiometric to the V_{RATIO} voltage, i.e., the null voltage, rate sensitivity, and temperature outputs are proportional to V_{RATIO} . So, it is most easily used with a supply-ratiometric ADC which results in self cancellation of errors due to minor supply variations. There is some small, usually negligible, error due to non-ratiometric behavior. Note that, in order to guarantee full rate range, V_{RATIO} should not be greater than AV_{CC}

MODIFYING THE MEASUREMENT RANGE

The ADXRS642 scale factor can be reduced to extend the measurement range to as much as $\pm 450^{\circ}\!/s$ by adding a single $225k\Omega$ resistor between the RATEOUT and SUMJ. If an external resistor is added between RATEOUT and SUMJ $C_{\rm OUT}$ must be proportionally reduced to maintain correct bandwidth.

NULL ADJUSTMENT

The nominal 2.5 V null is for a symmetrical swing range at RATEOUT (1B, 2A). However, a nonsymmetric output swing may be suitable in some applications. Null adjustment is possible by injecting a suitable current to SUMJ (1C, 2C). Note that supply disturbances may reflect some null instability. Digital supply noise should be avoided, particularly in this case.

SELF-TEST FUNCTION

The ADXRS642 includes a self-test feature that actuates each of the sensing structures and associated electronics in the same manner, as if subjected to angular rate. It is activated by standard logic high levels applied to Input ST1 (5F, 5G), Input ST2 (4F, 4G), or both. ST1 causes the voltage at RATEOUT to change about -0.3 V, and ST2 causes an opposite change of +0.3 V. The self-test response follows the viscosity temperature dependence of the package atmosphere, approximately $0.25\%/^{\circ}$ C.

Activating both ST1 and ST2 simultaneously is not damaging. ST1 and ST2 are fairly closely matched ($\pm 2\%$), but actuating both simultaneously may result in a small apparent null bias shift proportional to the degree of self-test mismatch.

ST1 and ST2 are activated by applying a voltage equal to V_{RATIO} to the ST1 pin and the ST2 pin. The voltage applied to ST1 and ST2 must never be greater than AV_{CC} .

CONTINUOUS SELF-TEST

The on-chip integration of the ADXRS642 gives it higher reliability than is obtainable with any other high volume manufacturing method. Also, it is manufactured under a mature BiMOS process that has field-proven reliability. As an additional failure detection measure, power-on self-test can be performed. However, some applications may warrant continuous self-test while sensing rate. Details outlining continuous self-test techniques are also available in the AN-768 Application Note.

MECHANICAL PERFORMANCE

The ADXRS642 excellent vibration rejection is demonstrated in the graphs below. Figure 6 shows the ADXRS642 output

response with and without 15g RMS 50Hz to 5kHz of random vibration. Bandwidth of the gyro was limited to 1600Hz. Performance is similar regardless of the direction of input vibration.

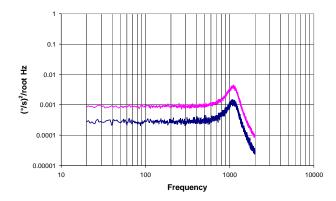


Figure 6. ADXRS642 Output Response With and Without Random Vibration (15g RMS, 50Hz to 5kHz)

Figure 7 demonstrates the ADXRS642 DC bias response to 5g Sine vibration over the 20Hz to 5kHz range. As can be seen, there are no sensitive frequencies present and vibration rectification is vanishingly small. As in the previous example gyro bandwidth was set to 1600Hz.

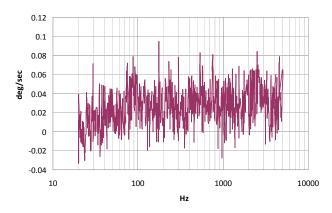
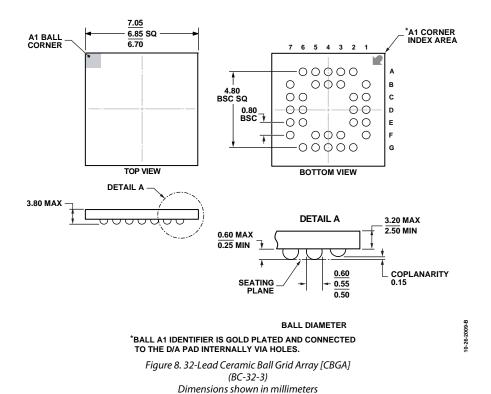


Figure 7. ADXRS642 Sine Vibration Output Response (5g, 20Hz to 5kHz)

OUTLINE DIMENSIONS



ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Package Option
ADXRS642BBGZ	-40°C to +105°C	32-Lead Ceramic Ball Grid Array [CBGA]	BC-32-3
ADXRS642BBGZ-RL	-40°C to +105°C	32-Lead Ceramic Ball Grid Array [CBGA]	BC-32-3
EVAL-ADXRS642Z		Evaluation Board	

¹ Z = RoHS Compliant Part.

NOTES

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